Notice of Allowability	Application No.	Applicant(s)	
	10/768,660	HILL ET AL. Art Unit	
House of Allowability	Examiner	Art Unit	
	Thinh T. Nguyen	2818	
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.			
1. This communication is responsive to <u>7/26/2005</u> .	. :		
2. The allowed claim(s) is/are <u>2-7,9-16 and 18-20</u> .			
3. The drawings filed on <u>02 February 2004</u> are accepted by the Examiner.			
4. ☐ Acknowledgment is made of a claim for foreign priority ur  a) ☐ All b) ☐ Some* c) ☐ None of the:  1. ☐ Certified copies of the priority documents have  2. ☐ Certified copies of the priority documents have	been received. been received in Application No		
<ol> <li>Copies of the certified copies of the priority do International Bureau (PCT Rule 17.2(a)).</li> </ol>	cuments have been received in this	national stage application from the	
* Certified copies not received:			
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	of this communication to file a reply IENT of this application.	complying with the requirements	
5. A SUBSTITUTE OATH OR DECLARATION must be subm INFORMAL PATENT APPLICATION (PTO-152) which give	itted. Note the attached EXAMINER es reason(s) why the oath or declara	'S AMENDMENT or NOTICE OF tion is deficient.	
6. CORRECTED DRAWINGS (as "replacement sheets") mus	st be submitted.		
(a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review ( PTO-948) attached			
1)  hereto or 2)  to Paper No./Mail Date			
(b) including changes required by the attached Examiner' Paper No./Mail Date	s Amendment / Comment or in the C	Office action of	
Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in t	.84(c)) should be written on the drawing the header according to 37 CFR 1.121(	ngs in the front (not the back) of d).	
<ol> <li>DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.</li> </ol>			
Attachment(s)			
Attachment(s) 1. ☐ Notice of References Cited (PTO-892)	5.  Notice of Informal F	Patent Application (PTO-152)	
2. $\square$ Notice of Draftperson's Patent Drawing Review (PTO-948)	6. Interview Summary		
3. Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date		Paper No./Mail Date 7.	
Examiner's Comment Regarding Requirement for Deposit of Biological Material	8. ⊠ Examiner's Stateme 9. ☐ Other	ent of Reasons for Allowance	
David Nelms Supervisory Patent Examiner Technology Center 2800			

U.S. Patent and Trademark Office PTOL-37 (Rev. 1-04)

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## **DETAILED ACTION**

### Reason for allowance

1. Claims 2-7,9-16,18-20 are allowed. The following is an examiner's statement of reason for allowance:

### I/ Group I: Claims 2-7:

None of the references of record teaches or suggests the claimed ISOLATED

FINFET P-CHANNEL/N-CHANNEL TRANSISTOR PAIR having the limitations:

- " a fin structure comprising a semi-conducting material. the tin structure including a channel stop laver, wherein the channel stop layer has a retrograde channel concentration profiles a source region formed at one end of the fin structure, the channel stop laver separating the source region into a first source region and a second source region.

a drain region formed at an opposite end of the tin structure. the channel stop layer separating the drain region into a first drain region and a second drain regions "--

and all other limitations as recited in claim 1.

# II/ Group II: Claims 9-16:

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None of the references of record teaches or suggests the claimed ISOLATED

FINFET P-CHANNEL/N-CHANNEL TRANSISTOR PAIR having the limitations:

- "a fin structure that includes a retrograde channel stop layer that extends a

length of the fin structure and is positioned approximately in a center of the fin

structure.

a source region formed at one end of the fin structure, the retrograde channel

stop laver separating the source region into a first source region and a second

source region a drain region formed at an opposite end of the fin structure. The

retrograde channel stop layer separating the drain region into a first drain region

and a second drain region, wherein the retrograde channel stop layer has a

retrograde channel concentration profile. "--

and all other limitations as recited in claim 9.

III/ Group III: Claims 18-20:

None of the references of record teaches or suggests the claimed **ISOLATED** 

FINFET P-CHANNEL/N-CHANNEL TRANSISTOR PAIR having the limitations:

-- "A semiconductor device comprising

an N-channel device including a first source regions a first drain region, a first

fin structures and a gates and a P-channel device including a second source region,

a second drain region, a second fin structure. and the gate. the second source

region the second drain region, and the second fin structure being separated from

the first source region. the first drain region. And the first fin structure by a

channel stop layer, wherein the channel stop layer has a retrograde channel concentration profile. "—

and all other limitations as recited in claim 18.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance".

#### Conclusion

2. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Thinh T Nguyen whose telephone number is 571-272-1790. The examiner can normally be reached on Monday-Friday 9:00am-6:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David Nelms can be reached at 571-272-1787. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 872-9306 for regular communications and (703) 872-9319 for After Final communications.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval [ PAIR ] system. Status information for

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published applications may be obtained from either Private PAIR or Public PAIR.

Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-

direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Thinh T Nguyen i

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David Nelms
Supervisory Patent Examiner

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Technology Center 2800